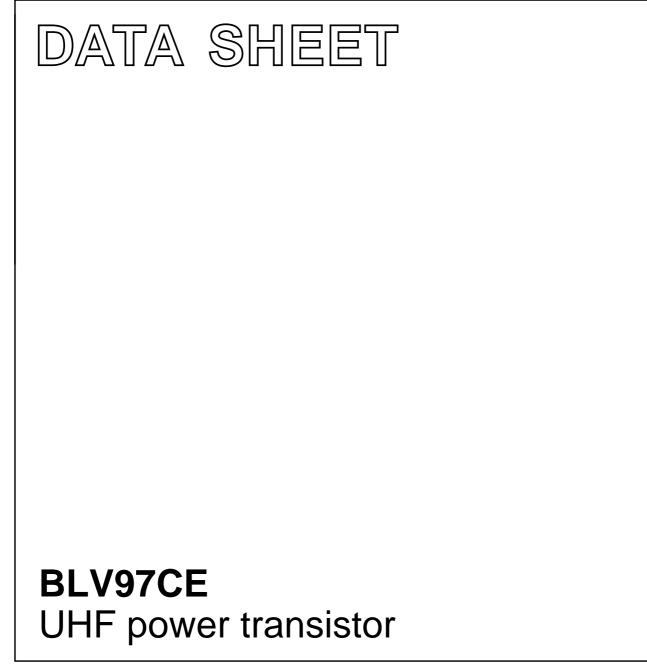
DISCRETE SEMICONDUCTORS



Product specification

March 1993



### BLV97CE

### FEATURES

- Internal input matching to achieve high power gain
- Ballasting resistors for an optimum temperature profile
- · Gold metallization ensures excellent reliability

### DESCRIPTION

NPN silicon planar epitaxial transistor in a SOT171 envelope, intended for common emitter, class-AB operation in radio transmitters for the 960 MHz communications band. The transistor has a 6-lead flange envelope, with a ceramic cap. All leads are isolated from the flange.

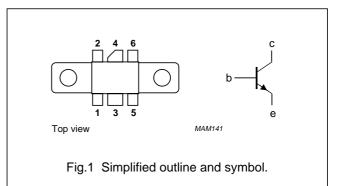
### QUICK REFERENCE DATA

RF performance up to  $T_h = 25$  °C in a common emitter class-AB circuit.

MODE OF OPERATION	f (MHz)	V <sub>CE</sub> (V)	P <sub>L</sub> (W)	G <sub>P</sub> (dB)	ղ <b>շ (%)</b>
c.w. class-AB	960	24	35	> 7	> 50

### PINNING - SOT171A

PIN	SYMBOL	DESCRIPTION
1	е	emitter
2	е	emitter
3	b	base
4	с	collector
5	е	emitter
6	е	emitter



### WARNING

#### Product and environmental safety - toxic materials

This product contains beryllium oxide. The product is entirely safe provided that the BeO disc is not damaged. All persons who handle, use or dispose of this product should be aware of its nature and of the necessary safety precautions. After use, dispose of as chemical or special waste according to the regulations applying at the location of the user. It must never be thrown out with the general or domestic waste.

### BLV97CE

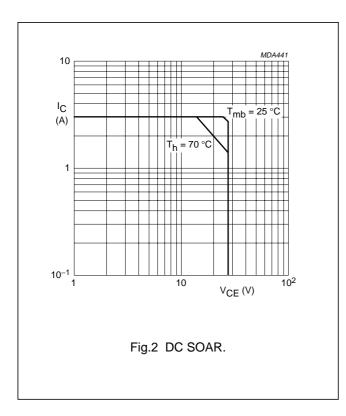
### LIMITING VALUES

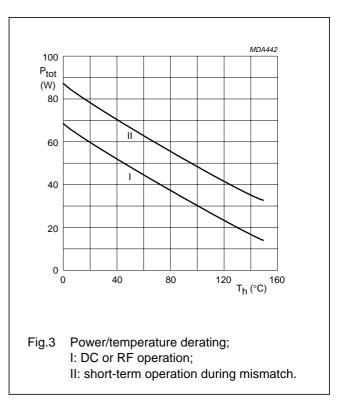
Limiting values in accordance with the Absolute Maximum System (IEC 134)

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V <sub>CBO</sub>	collector base voltage	open emitter	_	50	V
V <sub>CEO</sub>	collector emitter voltage	open base	-	27	V
V <sub>EBO</sub>	emitter base voltage	open collector	_	3.5	V
I <sub>C</sub>	collector current	DC or average	—	3	A
I <sub>CM</sub>	collector current	peak value f > 1 MHz	-	9	A
P <sub>tot</sub>	total power dissipation	f > 1 MHz T <sub>mb</sub> = 25 °C	-	70	W
T <sub>stg</sub>	storage temperature		-65	150	°C
Tj	operating junction temperature		_	200	°C

### THERMAL RESISTANCE

SYMBOL	SYMBOL PARAMETER		TYP.	MAX.	UNIT
R <sub>thj-mb</sub>	from junction to mounting base (RF)		-	2.3	K/W
R <sub>th mb-h</sub>	from mounting base to heatsink		-	0.4	K/W





# BLV97CE

### CHARACTERISTICS

at T<sub>j</sub> = 25 °C unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V <sub>(BR)CBO</sub>	collector-base breakdown voltage	open emitter I <sub>C</sub> = 50 mA	50	_	-	V
V <sub>(BR)CEO</sub>	collector-emitter breakdown voltage	open base I <sub>C</sub> = 100 mA	27	_	_	V
V <sub>(BR)EBO</sub>	emitter-base breakdown voltage	open collector I <sub>E</sub> = 10 mA	3.5	_	_	V
I <sub>CES</sub>	collector leakage current	V <sub>BE</sub> = 0 V <sub>CE</sub> = 27 V	-	_	10	mA
h <sub>FE</sub>	DC current gain	I <sub>C</sub> = 2 A V <sub>CE</sub> = 20 V	15	_	-	
C <sub>c</sub>	collector capacitance at f = 1 MHz	$I_{E} = I_{e} = 0$ $V_{CB} = 25 \text{ V}$	-	44	-	pF
C <sub>re</sub>	feedback capacitance at f = 1 MHz	I <sub>C</sub> = 0 V <sub>CE</sub> = 25 V	_	30	-	pF
C <sub>cf</sub>	collector-flange capacitance		-	2	-	pF

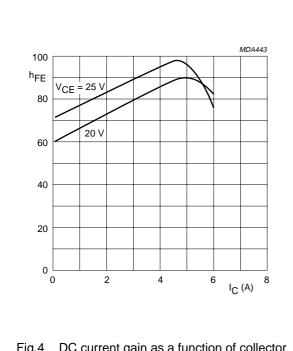


Fig.4 DC current gain as a function of collector current; typical values.

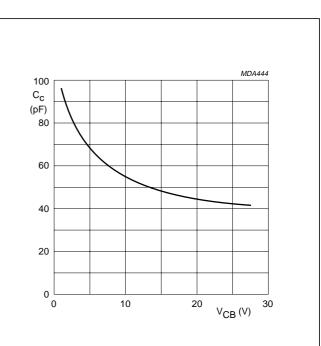


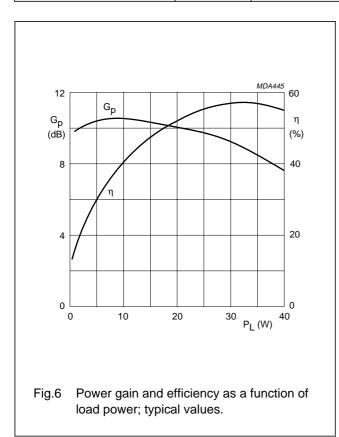
Fig.5 Output capacitance as a function of collector-base voltage; typical values.

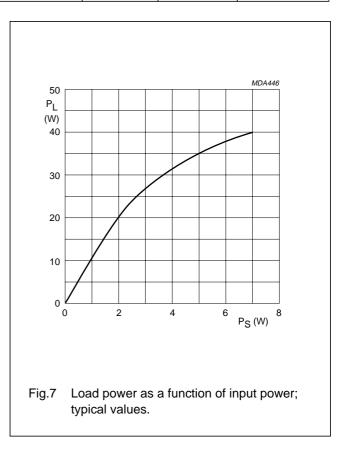
## BLV97CE

### **APPLICATION INFORMATION**

RF performance in a common emitter test circuit.  $T_h$  = 25 °C,  $R_{th mb-h}$  = 0.4 K/W unless otherwise specified.

MODE OF OPERATION	f (MHz)	V <sub>CE</sub> (V)	I <sub>C(ZS)</sub> (mA)	P <sub>L</sub> (W)	G <sub>P</sub> (dB)	ղ <b>շ (%)</b>
c.w. class-AB	960	24	60	35	> 7	> 50
					typ. 8.5	typ. 55

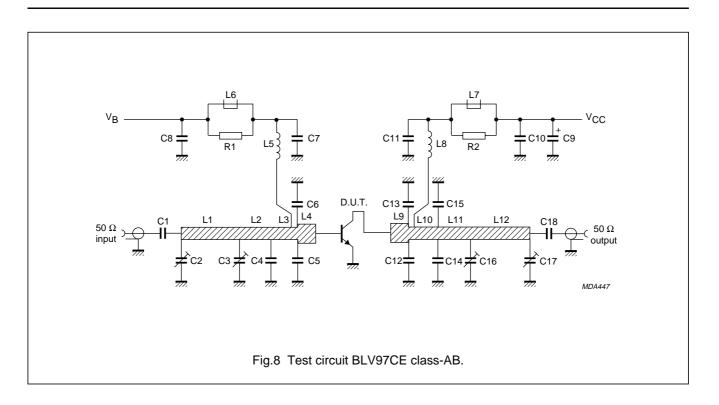




#### **Ruggedness in class-AB operation**

The BLV97CE is capable of withstanding a load mismatch corresponding to VSWR = 50 through all phases, under the following conditions:  $V_{CE} = 24$  V;  $I_{C(ZS)} = 120$  mA; f = 960 MHz at rated output power.

## BLV97CE



## BLV97CE

### List of components (Fig.9)

DESIGNATION	DESCRIPTION	VALUE	DIMENSIONS	CATALOGUE NO.
C1, C18	multilayer ceramic chip capacitor note 1	33 pF		
C2, C3, C16, C17	film dielectric trimmer	1.4 to 5.5 pF		2222 809 09001
C5, C6	multilayer ceramic chip capacitor note 2	3.3 pF		
C7, C11	multilayer ceramic chip capacitor note 1	10 pF		
C8	multilayer ceramic chip capacitor	100 nF		
C9	35 V solid aluminium capacitor	2.2 μF		2222 128 50228
C10	multilayer ceramic chip capacitor	$3 \times 100 \text{ nF}$ in parallel		
C12, C13	multilayer ceramic chip capacitor note 2	12 pF		
C14, C15	multilayer ceramic chip capacitor note 1	3.3 pF		
L1, L12	microstrip note 3	50 Ω	26 × 2.4 mm	
L2, L3	microstrip note 3	50 Ω	9.5 × 2.4 mm	
L4	microstrip note 3	42.6 Ω	$6.0 \times 3.0 \text{ mm}$	
L5	3 turns enamelled 1 mm copper wire	30 nH	int. dia. 4 mm length 3 mm leads $2 \times 5$ mm	
L6, L7	grade 3B ferroxcube wide-band RF choke			4312 020 36642
L8	4 turns enamelled 1 mm copper wire	45 nH	int. dia. 4 mm length 4 mm leads $2 \times 5$ mm	
L9	microstrip note 3	42.6 Ω	4.0 × 3.0 mm	
L10	microstrip note 3	50 Ω	9.0 × 2.4 mm	
L11	microstrip note 3	50 Ω	13.5 × 2.4 mm	
R1, R2	1 W metal film resistor	10 Ω		2322 153 51009

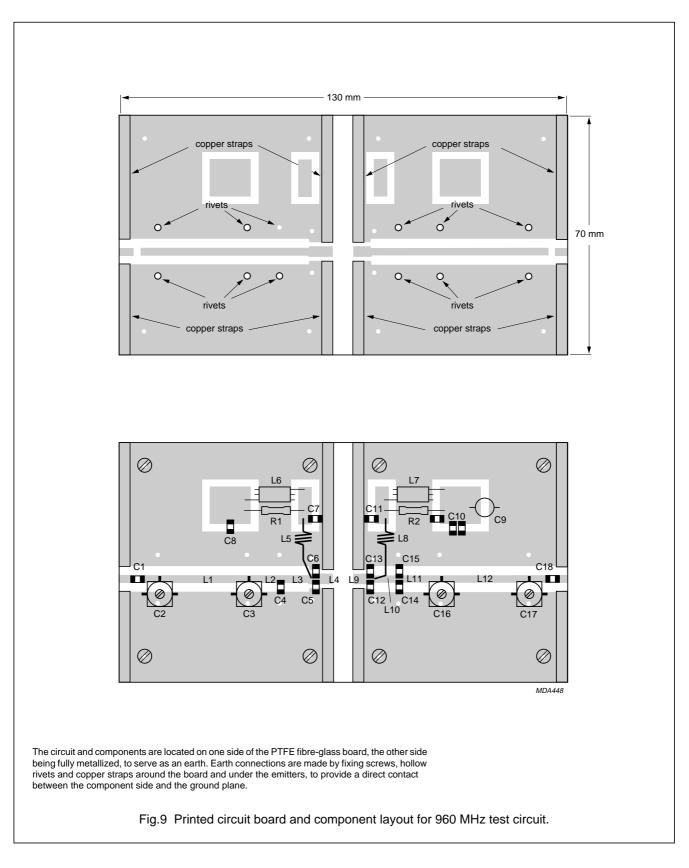
### Notes

1. ATC capacitor type 100B or capacitor of the same quality.

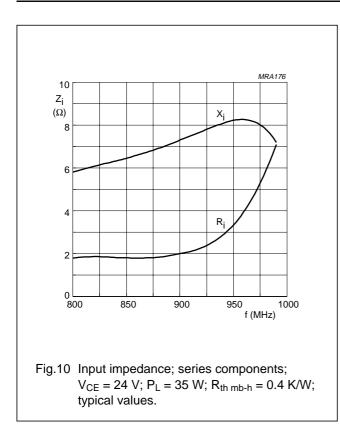
2. ATC capacitor type 100A or capacitor of the same quality.

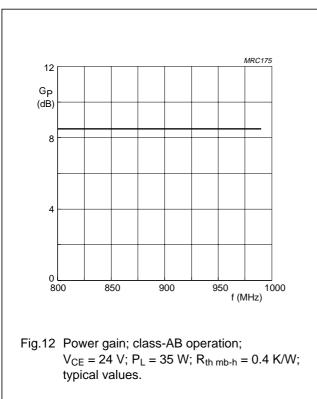
3. The microstrips are on a double copper-clad PCB with PTFE fibre-glass dielectric ( $\epsilon_r = 2.2$ ); thickness  $\frac{1}{32}$  inch.

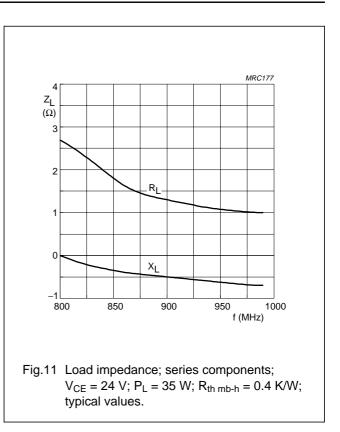
## BLV97CE



# BLV97CE

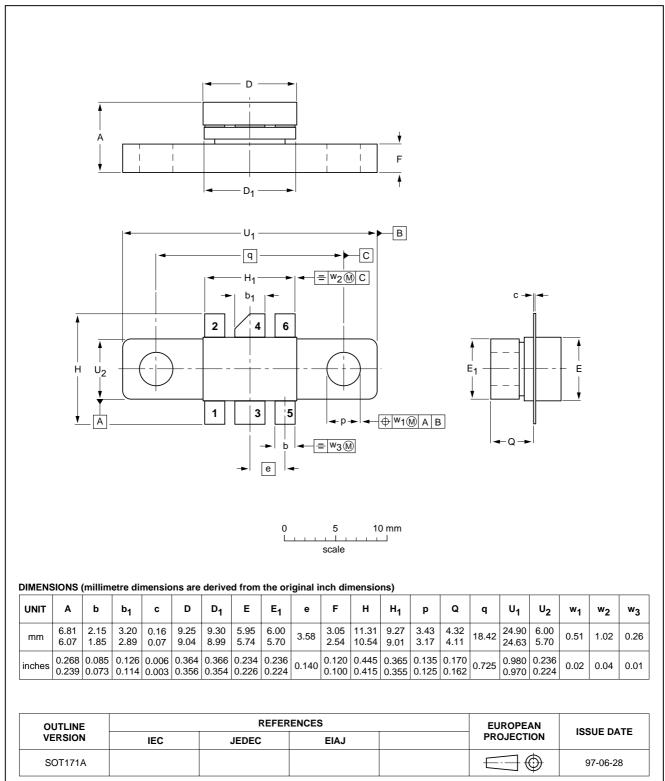






### PACKAGE OUTLINE

### Flanged ceramic package; 2 mounting holes; 6 leads



### BLV97CE

**SOT171A** 

BLV97CE

### DEFINITIONS

Data Sheet Status	
Objective specification	This data sheet contains target or goal specifications for product development.
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.
Product specification	This data sheet contains final product specifications.
Limiting values	
more of the limiting values m of the device at these or at a	accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or hay cause permanent damage to the device. These are stress ratings only and operation any other conditions above those given in the Characteristics sections of the specification miting values for extended periods may affect device reliability.
Application information	

Where application information is given, it is advisory and does not form part of the specification.

### LIFE SUPPORT APPLICATIONS

These products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips for any damages resulting from such improper use or sale.